Creep rupture induced silica-based nanofibers formed on fracture surfaces of Ti₃SiC₂

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After creep failure at 1300 $^{\circ}$ C, silica-based nanofibers with diameters of ~250 nm and lengths of up to a few tens of microns were observed on the fracture surfaces of Ti₃SiC₂. A possible mechanism for the formation of these fibers is proposed.

Ti₃SiC₂ is a representative compound of the $M_{n+1}AX_n$ (or MAX) phases, where M is an early transition metal, A is a group-A element, X is carbon and/or nitrogen, and n=1-3. By now it is fairly well established that Ti₃SiC₂ possesses good electrical conductivity (4.3 × 10⁶ Ω^{-1} m⁻¹) and thermal conductivity (39.9 W/mK), is relatively soft (HV 4 GPa), machinable, damage tolerant, and resistant to thermal shock.¹⁻⁶

Because of its good high-temperature mechanical properties and oxidation resistance,^{3,7,8} it is a promising candidate for high-temperature structural applications. For such applications, it is paramount to understand its creep response, which has been reported elsewhere.^{9,10} The purpose of this present article, however, is not to report on its creep behavior but to report on interesting features observed on fracture surfaces of samples that were crept at 1300 °C.

Coarse-grained (grain size $30{\text -}50~\mu\text{m}$) Ti_3SiC_2 cylinders (9.8 mm in diameter and 31 mm long) were loaded under a compressive stress of 100 MPa at 1300 °C in air until rupture (for details see Ref. 8). The creep strain at rupture was ~4%. The sample failed in a shear-like manner, with the fracture surface plane forming an angle of ~45° to the loading axis. The fracture surface was observed with an FEI-XL30 field emission scanning electron microscope (SEM) equipped with an energy-dispersive spectrum (EDS) analyzer.

Figure 1 shows an SEM micrograph of multiple nanofibers on the fracture surface. A higher magnification micrograph is shown in the inset. The nanofibers have a more or less circular cross-section, and appear as if they

^{a)}Address all correspondence to this author. e-mail: z.m.sun@aist.go.jp; barsoumw@drexel.edu DOI: 10.1557/JMR.2005.0381 were spun from a melt. Their diameter is \sim 250 nm, and their lengths vary from a few to over 50 μ m.

Figure 2 is an SEM micrograph of another set of nanofibers, where again the diameter is ~250 nm. The lower inset magnifies the root of the nanofiber, which is reminiscent of a tree root. The upper inset shows a node in the nanofiber that became charged in the SEM as it was scanned with the electron beam at a slow scan speed, indicating that it most likely is an electric insulator.

To determine the chemistries of various features shown in Figs. 1 and 2, individual nanofibers and faceted particles were retrieved from the fracture surfaces and affixed on a conductive carbon tape for EDS analysis. Figures 3(a) and 3(b) show the EDS spectra (with SEM micrographs as insets) of a single nanofiber (a) and a faceted particle (b) taken from the fracture surface, respectively. The quantitative results from the three spectra were summarized in the respective insets in Fig. 3. Excluding the strong C signal, contributed by the carbon tape, it is obvious that the nanofiber contains high concentrations of Si and O, and negligible Ti [Fig. 3(a)]. The faceted particle, on the other hand, contains a high concentration of Ti and O and negligible Si. The reason for the higher O content recorded is not clear at this time, but could be due to the O concentration in the carbon tape adhesive. Nevertheless, on the basis of previous oxidation results, ^{7,11} we believe the nanofibers have an SiO₂ chemistry and the faceted particles are most probably rutile or TiO₂. The EDS spectrum in Fig. 3(c), taken on the plate-shaped grain in Fig. 2 directly on the fracture surface, indicates that the Ti₃SiC₂ grains were also oxidized.

During the first few minutes of oxidation of Ti_3SiC_2 in air at high temperatures, a thin, ~600 nm, most probably amorphous, silicon oxide layer forms. ¹¹ Traces of this layer are sometimes found later in the oxidation process.

In Fig. 4 we propose a possible mechanism for the formation of these nanofibers. First we assume the formation of a simple transgranular crack of a single Ti₃SiC₂ grain [Figs. 4(a) and 4(b)]. Next, a thin SiO₂ layer forms and fills the crack [Fig. 4(c)]. Upon subsequent separation of the two halves of the grain, it is not

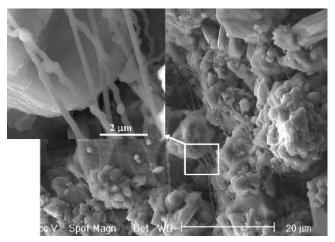


FIG. 1. Scanning electron micrograph of a Ti₃SiC₂ fracture surface after creep rupture at 1300 °C and 100 MPa, showing the nanofiber formation. Inset: details of the central part with tangled nanofibers.

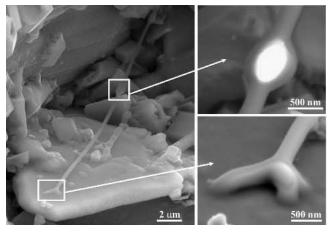


FIG. 2. A single nanofiber formed on a plate shaped grain. Insets: root of a nanofiber and a node in the middle of its length.

unreasonable to assume that the glassy film is drawn into fibers [Figs. 4(d) and 4(e)]. Further oxidation could then result in TiO_2 grains on the fracture surfaces that would grow with time, ultimately forming a layer on the surface (see Figs. 1 and 2).

Under such conditions, the diameters of the fibers would be determined by the thickness and viscosity of the SiO₂-based film formed on the fracture surface. This fairly uniform thickness of the nanofibers observed on the fracture surface in different locations could thus be a result of a more or less uniform thickness of this SiO₂-based film. If that is true, then it may be possible to

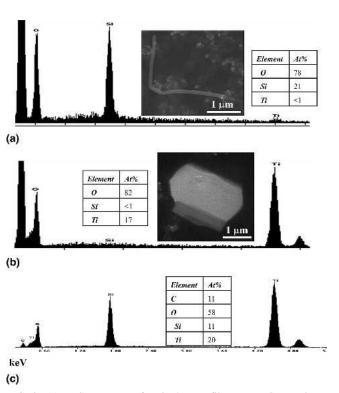


FIG. 3. (a) EDS spectrum of a single nanofiber. Inset: SEM micrograph of a nanofiber extracted from the fracture surface and placed on a conductive carbon tape. (b) EDS spectrum of a single faceted particle. Inset: SEM micrograph of a particle extracted from the fracture surface and placed on a conductive carbon tape. (c) EDS spectrum of a $\rm Ti_3SiC_2$ grain on the fracture surface.

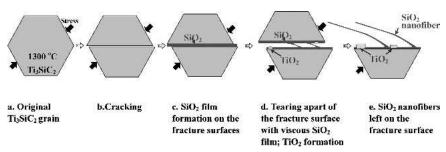


FIG. 4. Proposed mechanism for the formation of SiO₂ nanofibers.

produce different thicknesses of the nanofibers at different temperatures. The same would apply to the strain rates as well.

To estimate the depths from which Si would have to diffuse to form a typical nanofiber of, say, diameter 250 nm and length 20 µm (Fig. 2), we carried out a simple mass balance assuming the Si is coming exclusively from a plate-shaped Ti₃SiC₂ grain with dimensions of 10 μ m × 10 μ m × 2 μ m. Assuming the fiber formed has a SiO₂ chemistry, it should consume the Si of ~16 Si basal planes. Because it has previously been shown that Si diffusion occurs preferentially along the basal planes, 12 the most likely Si path to the surface location of its oxidation is diffusion along the basal planes followed by either surface diffusion and/or evaporation condensation. These comments notwithstanding, it is hereby acknowledged that more work is needed to better understand the process by which these fibers form. At the very least, the role of O and the possible formation of SiO need to be addressed.

The significance of the results shown herein lies in their indication one more time for the selective oxidation of the A-group element in the MAX phases.

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